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# FDMS6673BZ

## P-Channel PowerTrench<sup>®</sup> MOSFET

-30 V, -82 A, 6.8 mΩ

### Features

- Max  $r_{DS(on)}$  = 6.8 mΩ at  $V_{GS} = -10$  V,  $I_D = -15.2$  A
- Max  $r_{DS(on)}$  = 12.5 mΩ at  $V_{GS} = -4.5$  V,  $I_D = -11.2$  A
- Advanced Package and Silicon Combination for Low  $r_{DS(on)}$
- HBM ESD Protection Level of 8 kV Typical(Note 3)
- MSL1 Robust Package Design
- RoHS Compliant

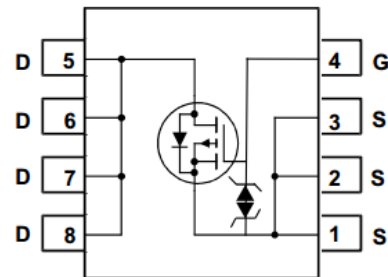
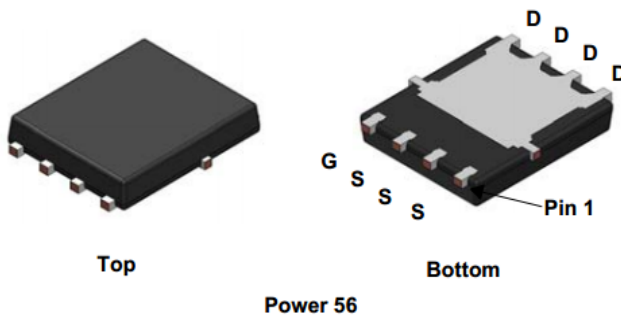


### General Description

The FDMS6673BZ has been designed to minimize losses in load switch applications. Advancements in both silicon and package technologies have been combined to offer the lowest  $r_{DS(on)}$  and ESD protection.

### Applications

- Load Switch in Notebook and Server
- Notebook Battery Pack Power Management



### MOSFET Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	Rated	Units
$V_{DS}$	Drain to Source Voltage	-30	V
$V_{GS}$	Gate to Source Voltage	$\pm 25$	V
$I_D$	Drain Current -Continuous	$T_C = 25^\circ\text{C}$ (Note 5)	-82
	-Continuous	$T_C = 100^\circ\text{C}$ (Note 5)	-52
	-Continuous	$T_A = 25^\circ\text{C}$ (Note 1a)	-15.2
	-Pulsed	(Note 4)	-422
$P_D$	Power Dissipation	$T_C = 25^\circ\text{C}$	73
	Power Dissipation	$T_A = 25^\circ\text{C}$ (Note 1a)	2.5
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

### Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.7	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

### Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS6673BZ	FDMS6673BZ	Power 56	13 "	12 mm	3000 units

## Electrical Characteristics $T_J = 25\text{ }^\circ\text{C}$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = -250\text{ }\mu\text{A}, V_{GS} = 0\text{ V}$	-30			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		-18		mV/°C
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -24\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
$I_{GSS}$	Gate to Source Leakage Current	$V_{GS} = \pm 25\text{ V}, V_{DS} = 0\text{ V}$			$\pm 10$	$\mu\text{A}$

### On Characteristics

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = -250\text{ }\mu\text{A}$	-1.0	-1.8	-3.0	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , referenced to $25\text{ }^\circ\text{C}$		7		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = -10\text{ V}, I_D = -15.2\text{ A}$		5.2	6.8	m $\Omega$
		$V_{GS} = -4.5\text{ V}, I_D = -11.2\text{ A}$		7.8	12.5	
		$V_{GS} = -10\text{ V}, I_D = -15.2\text{ A}, T_J = 125\text{ }^\circ\text{C}$		7.5	9.8	
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\text{ V}, I_D = -15.2\text{ A}$		76		S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = -15\text{ V}, V_{GS} = 0\text{ V},$ $f = 1\text{ MHz}$		4444	5915	pF
$C_{oss}$	Output Capacitance			781	1040	pF
$C_{rss}$	Reverse Transfer Capacitance			695	1045	pF
$R_g$	Gate Resistance			4.5		$\Omega$

### Switching Characteristics

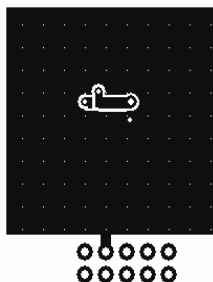
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -15\text{ V}, I_D = -15.2\text{ A},$ $V_{GS} = -10\text{ V}, R_{GEN} = 6\text{ }\Omega$		14	26	ns	
$t_r$	Rise Time			28	45	ns	
$t_{d(off)}$	Turn-Off Delay Time			97	156	ns	
$t_f$	Fall Time			79	127	ns	
$Q_g$	Total Gate Charge		$V_{GS} = 0\text{ V to } -10\text{ V}$		93	130	nC
$Q_g$	Total Gate Charge		$V_{GS} = 0\text{ V to } -5\text{ V}$		52	73	nC
$Q_{gs}$	Gate to Source Charge	$V_{DD} = -15\text{ V},$ $I_D = -15.2\text{ A}$		13		nC	
$Q_{gd}$	Gate to Drain "Miller" Charge			26		nC	

### Drain-Source Diode Characteristics

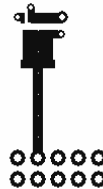
$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -2.1\text{ A}$ (Note 2)		0.7	1.20	V
		$V_{GS} = 0\text{ V}, I_S = -15.2\text{ A}$ (Note 2)		0.8	1.25	
$t_{rr}$	Reverse Recovery Time	$I_F = -15.2\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$		33	53	ns
$Q_{rr}$	Reverse Recovery Charge			20	32	nC

#### Notes:

1:  $R_{\theta JA}$  is determined with the device mounted on a  $1\text{ in}^2$  pad 2 oz copper pad on a  $1.5 \times 1.5\text{ in.}$  board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



a.  $50\text{ }^\circ\text{C/W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper.



b.  $125\text{ }^\circ\text{C/W}$  when mounted on a minimum pad of 2 oz copper.

2: Pulse Test: Pulse Width  $< 300\text{ }\mu\text{s}$ , Duty cycle  $< 2.0\%$ .

3: The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

4: Pulsed Id please refer to Fig 11 SOA graph for more details.

5: Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal/electro-mechanical application board design.

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted.

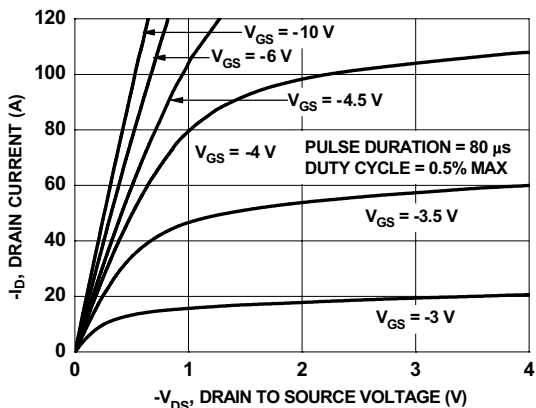


Figure 1. On Region Characteristics

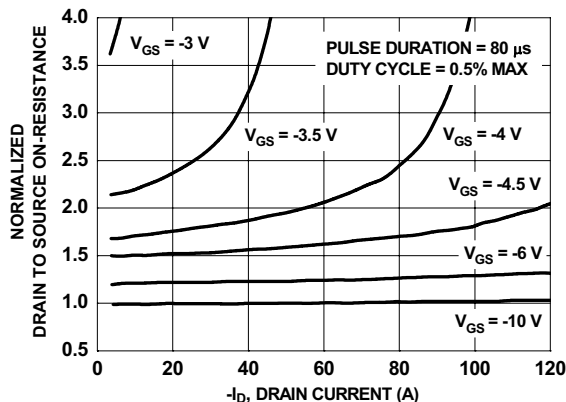


Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

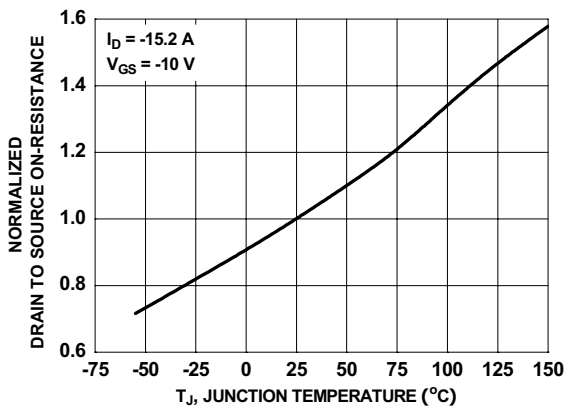


Figure 3. Normalized On Resistance vs. Junction Temperature

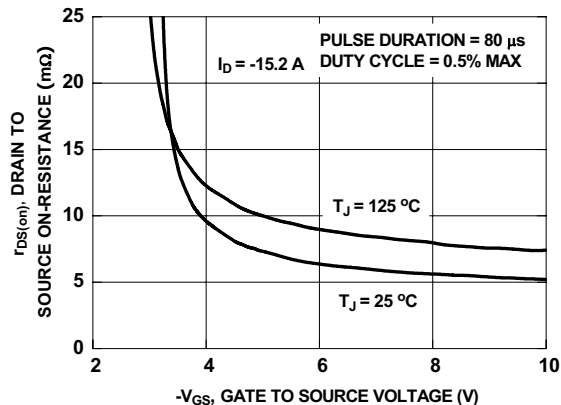


Figure 4. On-Resistance vs. Gate to Source Voltage

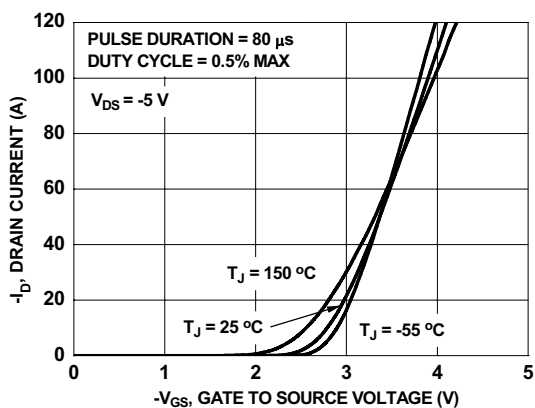


Figure 5. Transfer Characteristics

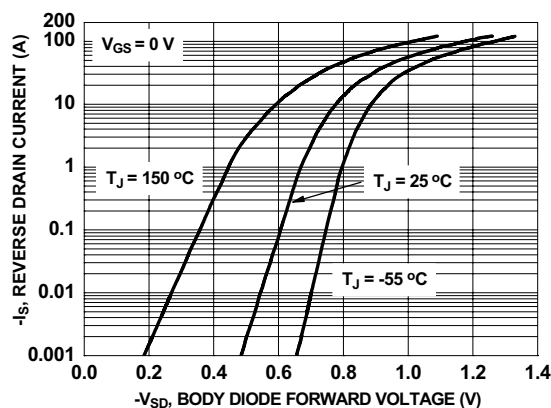
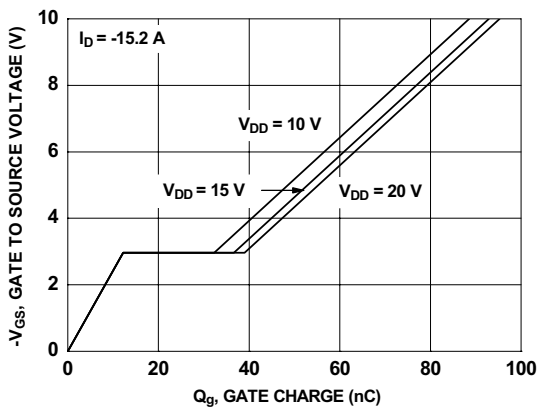
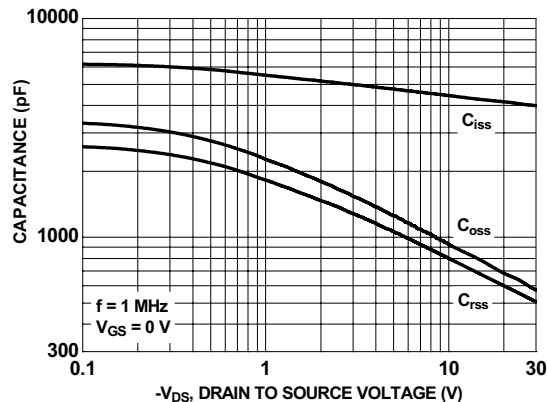


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

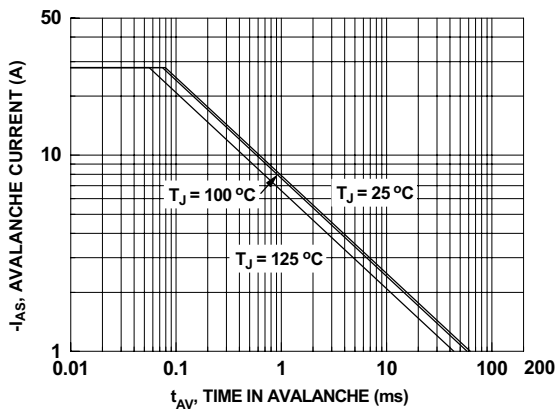
**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted.



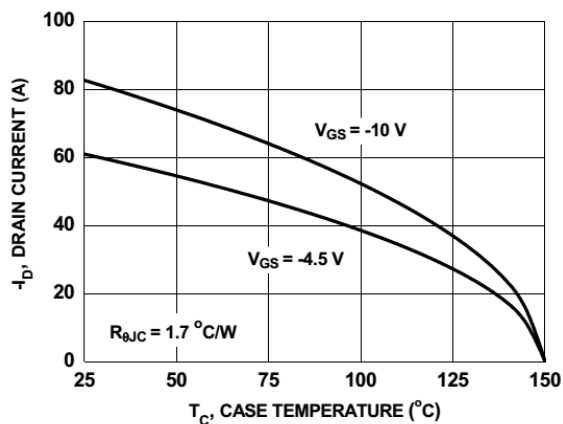
**Figure 7. Gate Charge Characteristics**



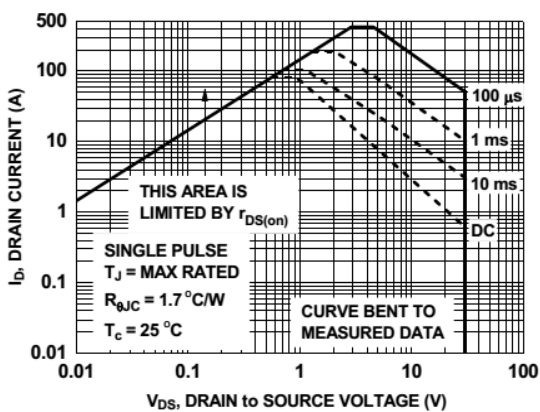
**Figure 8. Capacitance vs. Drain to Source Voltage**



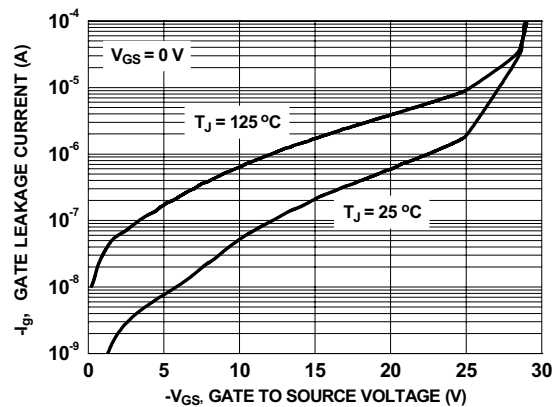
**Figure 9. Unclamped Inductive Switching Capability**



**Figure 10. Maximum Continuous Drain Current vs. Case Temperature**

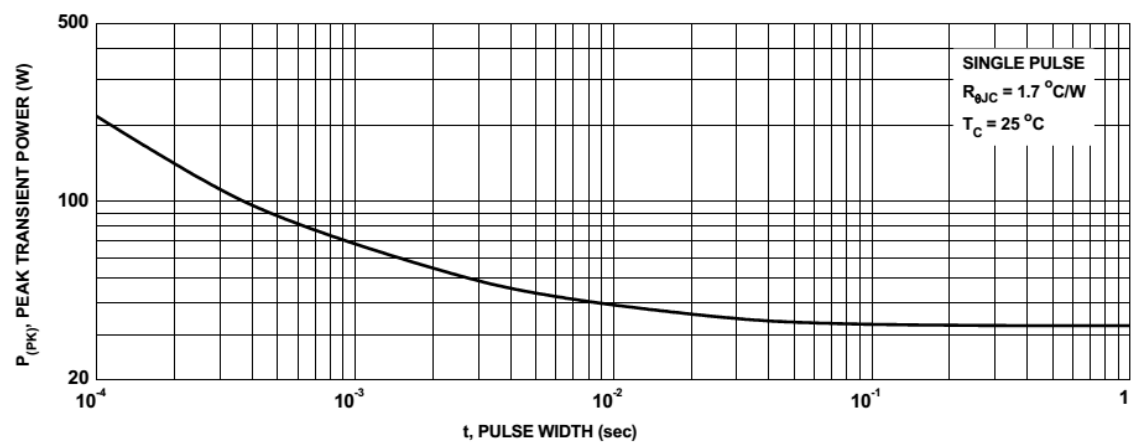


**Figure 11. Forward Bias Safe Operating Area**

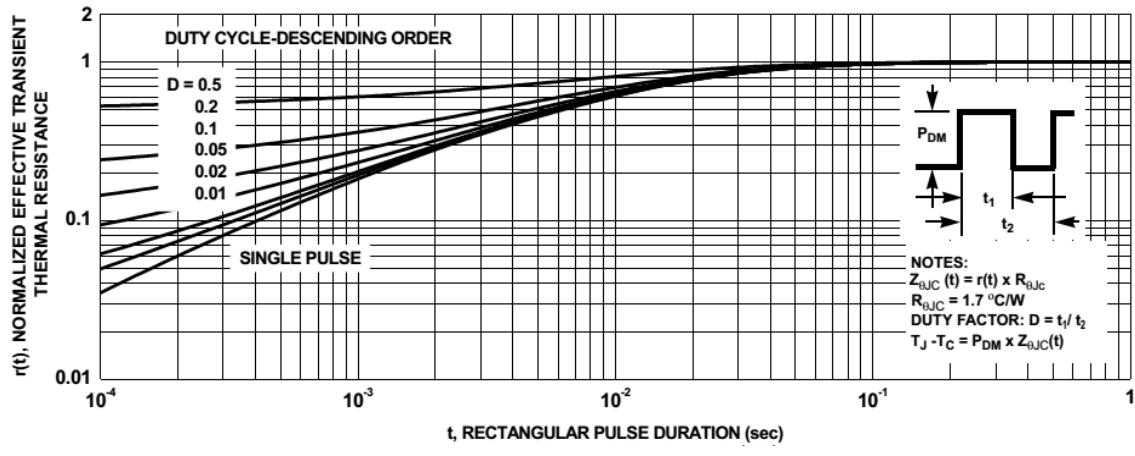


**Figure 12. Igs vs. Vgs**

**Typical Characteristics**  $T_J = 25\text{ }^\circ\text{C}$  unless otherwise noted.



**Figure 13. Single Pulse Maximum Power Dissipation**



**Figure 14. Junction-to-Case Transient Thermal Response Curve**

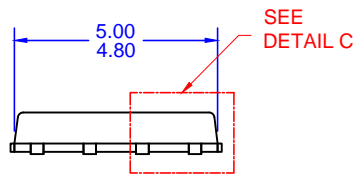
PQFN8 5X6, 1.27P  
CASE 483AE  
ISSUE A



TOP VIEW



LAND PATTERN RECOMMENDATION



SIDE VIEW

OPTIONAL DRAFT ANGLE MAY APPEAR ON FOUR SIDES OF THE PACKAGE



DETAIL C  
SCALE: 2:1



DETAIL B  
SCALE: 2:1



BOTTOM VIEW

NOTES: UNLESS OTHERWISE SPECIFIED

- A. PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA.
- B. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- E. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

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